

## Test Procedure for a High Voltage Card

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## Functional test procedure for High Voltage Card

### 1. SCOPE

1.1 This is a functional testing procedure for a High Voltage Card

### 2. STANDARDS OF QUALITY

2.1 Refer to the current revision of the IPC-A-610 standard for workmanship standards.

### 3. APPLICABLE DOCUMENTS

3.1 The following document(s) shall form part of this specification to the extent specified herein. Unless otherwise indicated, the latest issue shall apply.

3.1.1 **UUT documentation folder**

### 4. ENGINEERING REQUIREMENTS

#### 4.1 Equipment Cleaning

4.1.1 Equipment should be clean and free of debris prior to applying power unless performing an initial check. Refer to the local documented procedures for cleaning guidelines.

#### 4.2 Equipment Inspection

4.2.1 Equipment should be visually inspected for any defects prior to applying power. This inspection should include the following as a minimum:

4.2.1.1 Wires broken or cracked

4.2.1.2 Terminal strips / connectors broken or cracked

4.2.1.3 Loose wires

4.2.1.4 Components visually damaged

4.2.1.5 Capacitors leaking

4.2.1.6 Solder joints damaged or cold

4.2.1.7 Circuit board burned or de-laminated

4.2.1.8 Printed wire runs burned or damaged

### 5. EQUIPMENT REQUIRED

5.1 The following equipment is required to perform the process requirements. Equipment may be substituted provided that all accuracy's and test ratios are equivalent or better.

Qty	Reference #	Description
1		Fluke 85 DMM (or Equivalent)
1		O-Scope
1		115 VAC line cord
1		28 VDC Power Supply
1		SCR Firing Box

## 6. TESTING PROCESS

### 6.1.1 Attenuator Resistor Test (Voltage) NHVB

**6.1.1.1** To test the attenuator resistors, 10.000VDC+/- 1 mv is input with the polarity indicated and the output is read from output pin listed to JT (COM).

IN (+)	IN (-)	Output	Nom. Voltage	Max. Range
JD2-1	JD2-11	JA-28	-61.2 mv	-58.3 to -64.1 mv
		JA-17	+30.8 mv	+29.1 to +32.1 mv
		JA-27	+30.8 mv	+29.1 to +32.1 mv
JD2-6	JD2-11	JA-19	+45.8 mv	+ 44.1 to +47.7 mv
		JA-28	-45.8 mv	-44.1 to -47.7 mv
JD2-11	JD2-1	JA-28	+61.2 mv	+53.3 to +64.1 mv
		JA-27	-30.8 mv	-29.1 to -32.1 mv
		JA-17	-30.8 mv	-29.1 to -32.1 mv
JD1-1	JD1-7	JA-23	+45.9 mv	+44.8 to +47.0 mv
		JA-21	-45.9 mv	-44.8 to -47.0 mv
		JA-32	+45.9 mv	+44.8 to + 47.0 mv
		JA-29	-45.9 mv	-44.8 to -47.0 mv

### 6.1.2 CT INPUT TEST: (NHVB)

**6.1.2.1** Connect a 28-ohm 2W resistor across the daughter board terminals 1A and ACOM. Connect a scope across the resistor. Apply an isolated 6.3VAC (USE AN ISOLATION TRANSFORMER WITH THE VARIAC) to JC-1-JC-6. See a full wave waveform of only positive peaks approx. 7.7volts high.

**6.1.2.2** Move the AC input to JC-2 – JC-3 and see the same waveform.

**6.1.2.3** Move the AC input to JC-4 – JC-5 and see the same waveform. Disconnect the input, resistor and scope.

### **6.1.3 CT CLAMP TEST: (NHVB)**

**6.1.3.1.1** Apply +28V through a 180 ohm 2 watt resistor to JA34 (+) and JA20 (-). The voltage at JA34 (+) to JA20 (com) must be 16V +/- 2V.

### **6.1.4 Neon Lamp Test**

**6.1.4.1** Connect the AC line cord per table 2 and apply power to check each neon. Neon glows dimly on 120 VAC.

<b>DS3800NHVB</b>	<b>Point A</b>	<b>Point B</b>	<b>Neon</b>
Circuit # 1	JE-8	JE-2	DS1
Circuit # 2	JF-8	JF-3	DS-3
Circuit # 3	JG-8	JG-2	DS-5
Circuit # 4	JH-8	JH-1	DS-2
Circuit # 5	JJ-8	JJ-3	DS-4
Circuit # 6	JK-8	JK-3	DS-6

### 6.1.5 Firing Circuit & LED Test

**6.1.5.1** Using the information in the table apply a non-isolated negative pulse from the SCR Firing box to each circuit and verify with the scope a controllable pulse train output on each circuit.

**6.1.5.2** Verify that the LED for each circuit illuminates dimly using the information in this table.

DS3800NHVB	SCR Box COM	SCR Box NEG	Scope +	Scope -	28VDC +	28VDC-
Circuit # 1	JA-3	JA-4	JE-1	JE-2	JA-1	TAB
Circuit # 2	JA-3	JA-6	JF-1	JF-3	JA-1	TAB
Circuit # 3	JA-3	JA-8	JG-3	JG-2	JA-1	TAB
Circuit # 4	JA-3	JA-10	JH-2	JH-1	JA-1	TAB
Circuit # 5	JA-3	JA-12	JJ-1	JJ-3	JA-1	TAB
Circuit # 6	JA-3	JA-14	JK-2	JK-3	JA-1	TAB

**Note 1:** NHVB amplitude is 17 volts.

**Note 2:** 28 VDC COM to SCR Box COM

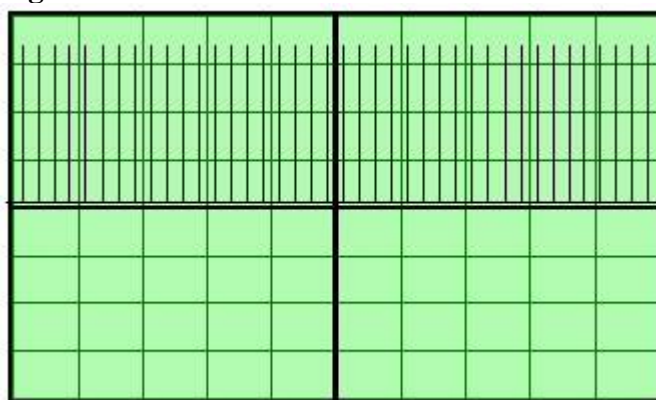
### 6.2 \*TEST COMPLETE \* SEAL POTS ON TEMP SENSOR CARDS

#### 7. NOTES

Output voltages (Waveforms) of gate circuits are measured with output unloaded.

#### 8. Oscilloscope Verification Examples:

**Fig. 1**



**DS3800NHVB**

**17V Peak 5V/Div**

**.5ms/Div**